


<b>Search Notes</b> 	<b>Application/Control No.</b> 10566705	<b>Applicant(s)/Patent Under Reexamination</b> ICHIKAWA ET AL.
	<b>Examiner</b> Eunhee Kim	<b>Art Unit</b> 2123

SEARCHED			
Class	Subclass	Date	Examiner
703	22	4/11/2008	Eunhee Kim

SEARCH NOTES		
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East Text search (See attached)	4/11/2008	Eunhee Kim

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